

RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

SSD12P10 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

TO-252 package is universally preferred for all commercial-industrial surface mount applications.

FEATURES

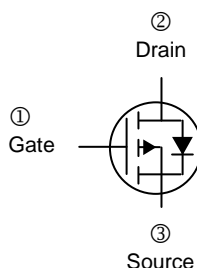
- Simple Drive Requirement
- Lower On-resistance
- Fast Switching Characteristic
- RoHS Compliant

MARKING

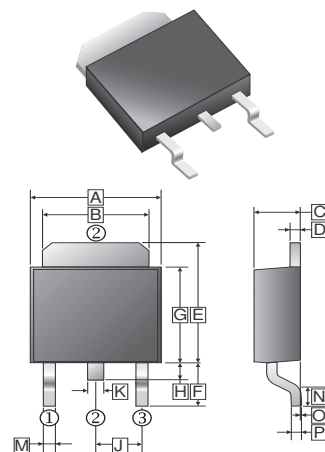


PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-252	2.5K	13 inch



TO-252(D-Pack)



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.35	6.90	J	2.336	REF.
B	4.95	5.50	K	0.89	REF.
C	2.10	2.50	M	0.50	1.14
D	0.43	0.9	N	1.3	1.8
E	6.0	7.5	O	0	0.13
F	2.90	REF.	P	0.58	REF.
G	5.40	6.40			
H	0.60	1.20			

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit	
Drain-Source Voltage	V_{DS}	-100	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current @ $V_{GS}=10\text{V}$	I_D	$T_C=25^\circ\text{C}$	-12	A
		$T_C=100^\circ\text{C}$	-10	A
Pulsed Drain Current ¹	I_{DM}	-48	A	
Total Power Dissipation	P_D	35.7	W	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$	
Thermal Resistance Rating				
Maximum Thermal Resistance from Junction to Case	$R_{\theta JC}$	3.5	$^\circ\text{C} / \text{W}$	
Maximum Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	110	$^\circ\text{C} / \text{W}$	

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Drain-Source Breakdown Voltage	BV_{DSS}	-100	-	-	V	$V_{GS}=0, I_D = -250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_J$	-	-0.096	-	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1\text{mA}$
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-	-2.5	V	$V_{DS}=V_{GS}, I_D = -250\mu\text{A}$
Forward Transconductance	g_{fs}	-	8	-	S	$V_{DS} = -10\text{V}, I_D = -8\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS} = \pm 32\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	-1	μA	$V_{DS} = -100\text{V}, V_{GS}=0, T_J = 25^\circ\text{C}$
Drain-Source Leakage Current		-	-	-25		$V_{DS} = -80\text{V}, V_{GS}=0, T_J = 150^\circ\text{C}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	210	m Ω	$V_{GS} = -10\text{V}, I_D = -8\text{A}$
		-	-	250		$V_{GS} = -4.5\text{V}, I_D = -6\text{A}$
Total Gate Charge ²	Q_g	-	16	-	nC	$V_{DS} = -80\text{V}$ $V_{GS} = -4.5\text{V}$ $I_D = -8\text{A}$
Gate-Source Charge	Q_{gs}	-	4.4	-		
Gate-Drain ("Miller") Charge	Q_{gd}	-	8.7	-		
Turn-on Delay Time ²	$T_{d(on)}$	-	9	-	nS	$V_{DS} = -50\text{V}$ $V_{GS} = -10\text{V}$ $R_G = 3.3\Omega$ $R_D = 6.25\Omega$ $I_D = -8\text{A}$
Rise Time	T_r	-	14	-		
Turn-off Delay Time	$T_{d(off)}$	-	45	-		
Fall Time	T_f	-	40	-		
Input Capacitance	C_{iss}	-	1590	-	pF	$V_{GS}=0$ $V_{DS} = -25\text{V}$ $f = 1\text{MHz}$
Output Capacitance	C_{oss}	-	110	-		
Reverse Transfer Capacitance	C_{rss}	-	70	-		
Gate Resistance	R_g	-	8	12	Ω	$f = 1\text{MHz}$
Source-Drain Diode Characteristics						
Forward On Voltage ²	V_{SD}	-	-	-1.3	V	$I_S = -12\text{A}, V_{GS}=0$
Continuous Source Current (Body Diode)	I_S	-	-	-12	A	$V_D = V_G = 0\text{V}$, Force Current
Pulsed Source Current (Body Diode) ¹	I_{SM}	-	-	-48	A	

Notes:

- The pulse width is limited by the safe operating area.
- Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

CHARACTERISTIC CURVES

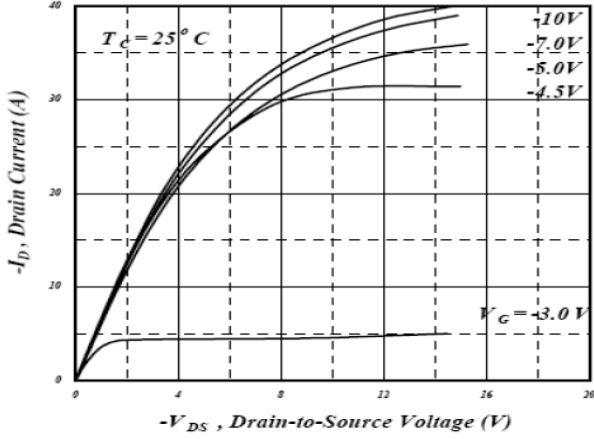


Fig 1. Typical Output Characteristics

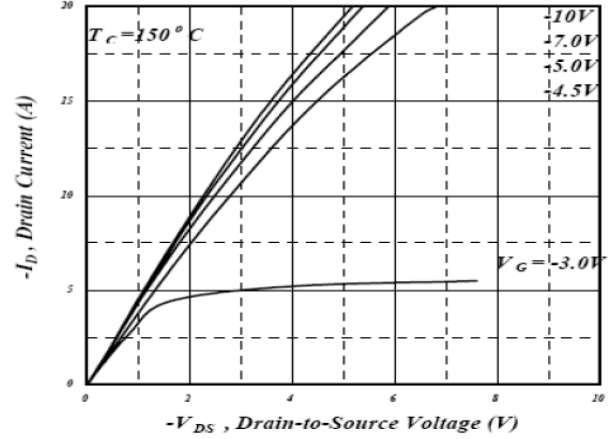


Fig 2. Typical Output Characteristics

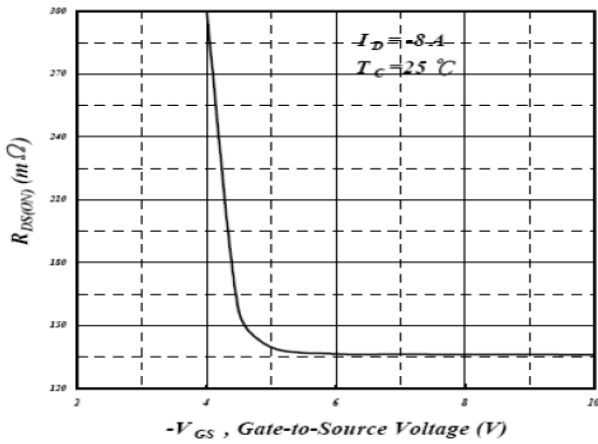


Fig 3. On-Resistance v.s. Gate Voltage

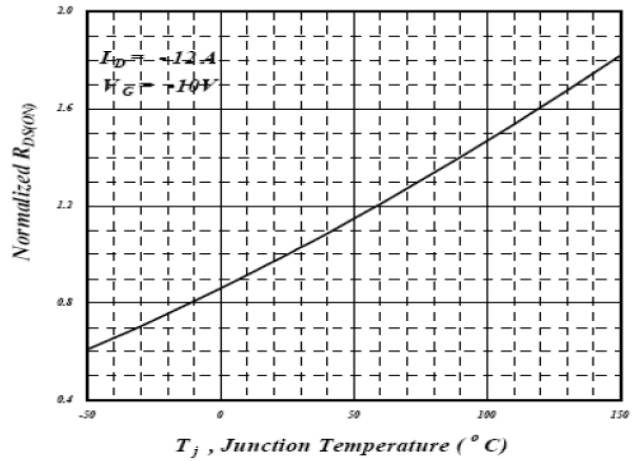


Fig 4. Normalized On-Resistance v.s. Junction Temperature

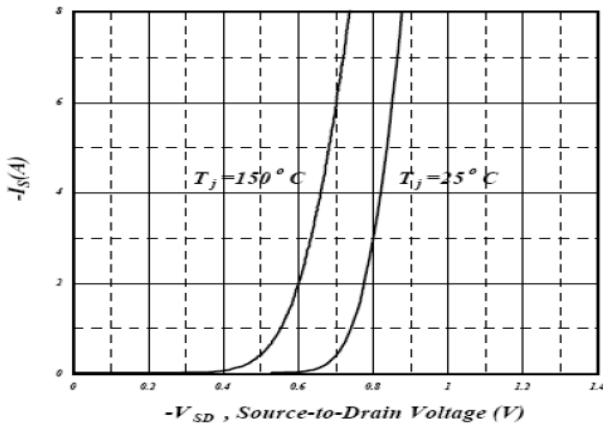


Fig 5. Forward Characteristic of Reverse Diode

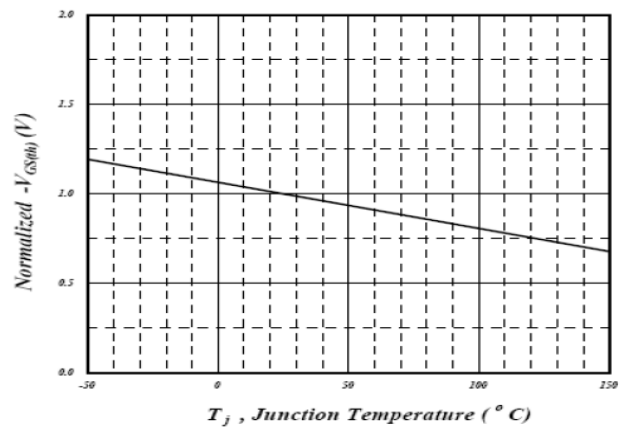


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

CHARACTERISTIC CURVES

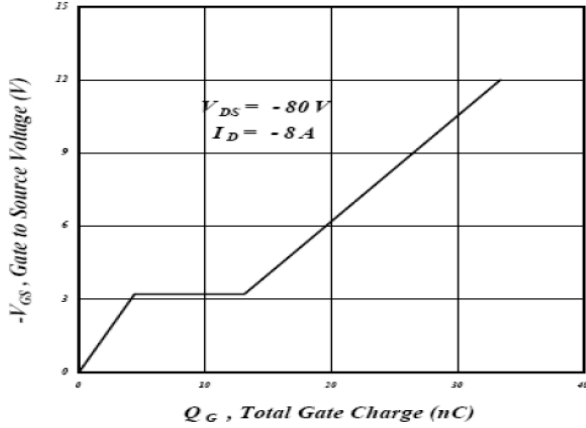


Fig 7. Gate Charge Characteristics

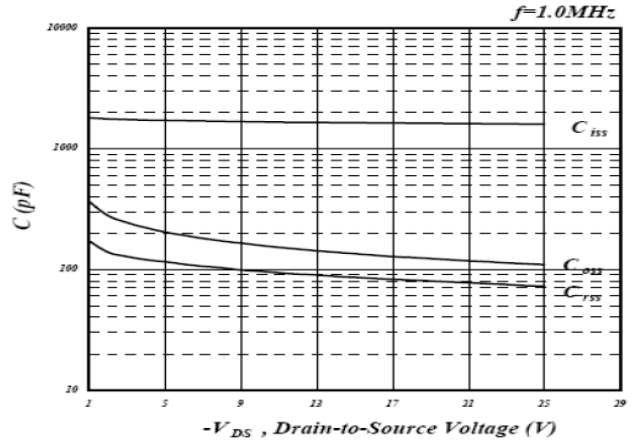


Fig 8. Typical Capacitance Characteristics

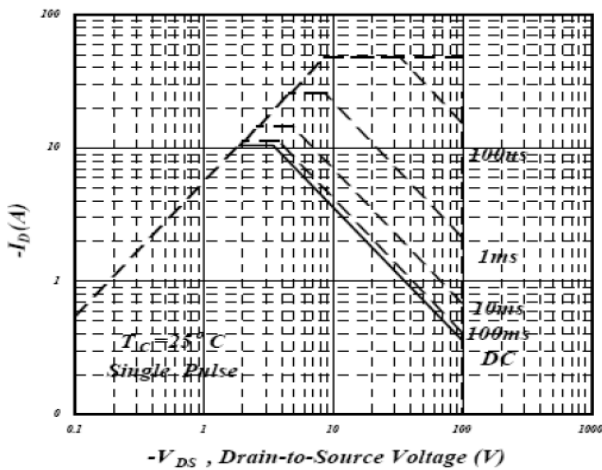


Fig 9. Maximum Safe Operating Area

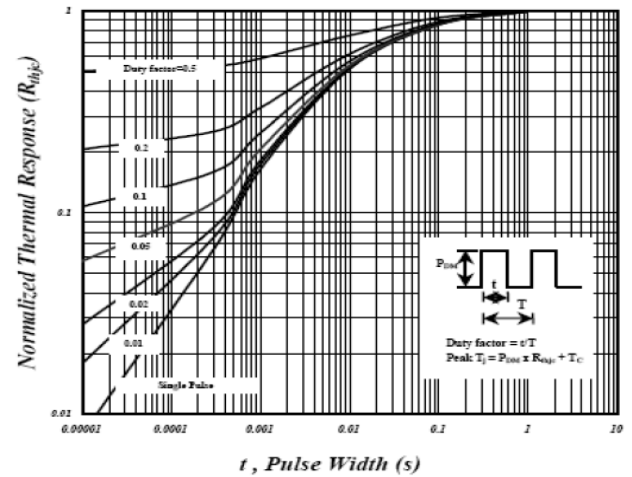


Fig 10. Effective Transient Thermal Impedance

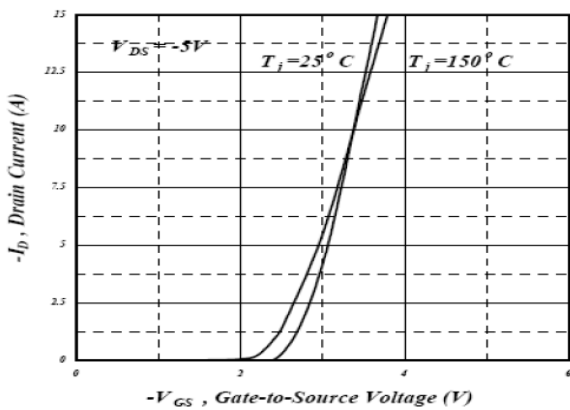


Fig 11. Transfer Characteristics

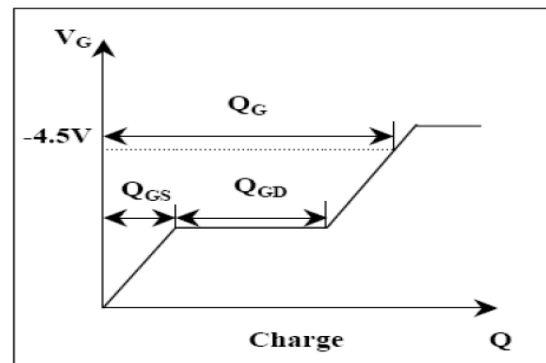


Fig 12. Gate Charge Waveform